

Dual P-Channel 8 V (D-S) MOSFET

| PRODUCT SUMMARY | | | | |
|---------------------|--|--------------------|-----------------------|--|
| V _{DS} (V) | $R_{DS(on)}(\Omega)$ | I _D (A) | Q _g (Typ.) | |
| | $0.080 \text{ at V}_{GS} = -4.5 \text{ V}$ | - 4 ^a | | |
| - 8 | 0.117 at V _{GS} = - 2.5 V | - 4 ^a | 4 nC | |
| | 0.170 at V _{GS} = - 1.8 V | - 3.5 | | |

FEATURES

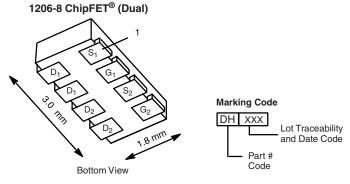
- Halogen-free According to IEC 61249-2-21
- TrenchFET® Power MOSFETs
- Compliant to RoHS Directive 2002/95/EC



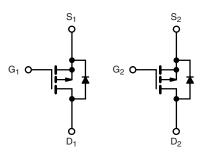


APPLICATIONS

Load Switch for Portable Devices



Ordering Information: Si5905BDC-T1-E3 (Lead (Pb)-free) Si5905BDC-T1-GE3 (Lead (Pb)-free and Halogen-free)



P-Channel MOSFET

P-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS T _A = 25 °C, unless otherwise noted | | | | | |
|---|-----------------------------------|-----------------|-----------------------|------|--|
| Parameter | | Symbol | Limit | Unit | |
| Drain-Source Voltage | | V_{DS} | - 8 | V | |
| Gate-Source Voltage | | V_{GS} | ± 8 | V | |
| | T _C = 25 °C | | - 4 ^a | | |
| Continuous Drain Current (T _{.1} = 150 °C) | T _C = 70 °C |] - | - 4 ^a | | |
| Continuous Brain Garrent (1) = 100 °C) | T _A = 25 °C | I _D | - 3.5 ^{b, c} | | |
| | T _A = 70 °C | | - 2.8 ^{b, c} | Α | |
| Pulsed Drain Current | | I _{DM} | - 10 | | |
| Continuous Source-Drain Diode Current | T _C = 25 °C | I _S | - 2.6 | | |
| Continuous Godice Brain Blode Guirent | T _A = 25 °C | '8 | - 1.2 ^{b, c} | | |
| | T _C = 25 °C | | 3.1 | | |
| Maximum Power Dissipation | $T_C = 70 ^{\circ}C$ | P _D | 2 | w | |
| Waximum rower Dissipation | T _A = 25 °C | . Б | 1.5 ^{b, c} | V | |
| | T _A = 70 °C | | 0.94 ^{b, c} | | |
| Operating Junction and Storage Temperature Ran | T _J , T _{stg} | - 55 to 150 | °C | | |
| Soldering Recommendations (Peak Temperature) | | 260 |) | | |

| THERMAL RESISTANCE RATINGS | | | | | | |
|---|--------------|------------|---------|---------|--------|--|
| Parameter | | Symbol | Typical | Maximum | Unit | |
| Maximum Junction-to-Ambient ^{b, f} | t ≤ 5 s | R_{thJA} | 70 | 85 | °C/W | |
| Maximum Junction-to-Foot (Drain) | Steady State | R_{thJF} | 33 | 40 |] 0/** | |

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- d. See Solder Profile (www.vishay.com/ppg?73257). The 1206-8 ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 120 °C/W.

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| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit | |
|---|-------------------------|---|--------|-------|-------|----------------|--|
| Static | - | | L | | l | 1 | |
| Drain-Source Breakdown Voltage | V_{DS} | $V_{GS} = 0 \text{ V, I}_{D} = -250 \mu\text{A}$ | - 8 | | | V | |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | L 050A | | - 7 | | mV/°C | |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | - I _D = - 250 μA | | 2 | | | |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$ | - 0.45 | | - 1.0 | V | |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$ | | | ± 100 | nA | |
| | I _{DSS} | V _{DS} = -8 V, V _{GS} = 0 V | | | - 1 | <u>μ</u> Α | |
| Zero Gate Voltage Drain Current | | V _{DS} = -8 V, V _{GS} = 0 V, T _J = 85 °C | | | - 10 | | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$ | - 10 | | | Α | |
| | , | V _{GS} = - 4.5 V, I _D = 3.3 A | | 0.066 | 0.080 | Ω | |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | V _{GS} = - 2.5 V, I _D = - 2.5 A | | 0.097 | 0.117 | | |
| | | V _{GS} = - 1.8 V, I _D = - 0.6 A | | 0.140 | 0.170 | | |
| Forward Transconductance ^a | g _{fs} | V _{DS} = - 4 V, I _D = - 3.3 A | | 8 | | S | |
| Dynamic ^b | | | | | | | |
| Input Capacitance | C _{iss} | | | 350 | | pF | |
| Output Capacitance | C _{oss} | V _{DS} = - 4 V, V _{GS} = 0 V, f = 1 MHz | | 140 | | | |
| Reverse Transfer Capacitance | C _{rss} | , do - , | | 85 | | | |
| Tieroico manoier Capacitantes | | V _{DS} = - 4 V, V _{GS} = - 8 V, I _D = - 3.7 A | | 7 | 11 | + | |
| Total Gate Charge | Q _g | V _{DS} = -4 V, V _{GS} = -4.5 V, I _D = -3.7 A | | 4 | 6 | nC | |
| Gate-Source Charge | | | | 0.65 | _ | | |
| Gate-Drain Charge | Q _{gd} | | | 0.75 | | | |
| Gate Resistance | R _g | f = 1 MHz | | 5.5 | | Ω | |
| Turn-On Delay Time | t _{d(on)} | | | 10 | 15 | | |
| Rise Time | t _r | $V_{DD} = -4 \text{ V}, R_1 = 1.3 \Omega$ | | 25 | 40 | - - - ns | |
| Turn-Off Delay Time | t _{d(off)} | $I_D \cong -3 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_q = 1 \Omega$ | | 20 | 30 | | |
| Fall Time | t _f | j | | 7 | 15 | | |
| Turn-On Delay Time | t _{d(on)} | | | 5 | 10 | | |
| Rise Time | t _r | $V_{DD} = -4 \text{ V, R}_{L} = -1.3 \Omega$ | | 10 | 15 | | |
| Turn-Off Delay Time | t _{d(off)} | | | 17 | 30 | | |
| Fall Time | t _f | j | | 10 | 15 | | |
| Drain-Source Body Diode Characteristic | s | | L | | | | |
| Continuous Source-Drain Diode Current | I _S | T _C = 25 °C | | | - 4 | l . | |
| Pulse Diode Forward Current | I _{SM} | | | | - 10 | A | |
| Body Diode Voltage | V_{SD} | I _S = - 3 A, V _{GS} = 0 V | | - 0.8 | - 1.2 | V | |
| Body Diode Reverse Recovery Time | ime t _{rr} | | | 55 | 85 | ns | |
| Body Diode Reverse Recovery Charge | | | | 25 | 50 | nC | |
| Reverse Recovery Fall Time | t _a | $I_F = -3 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 °\text{C}$ | | 14 | | † | |
| Reverse Recovery Rise Time | t _b | | | 41 | | ns | |

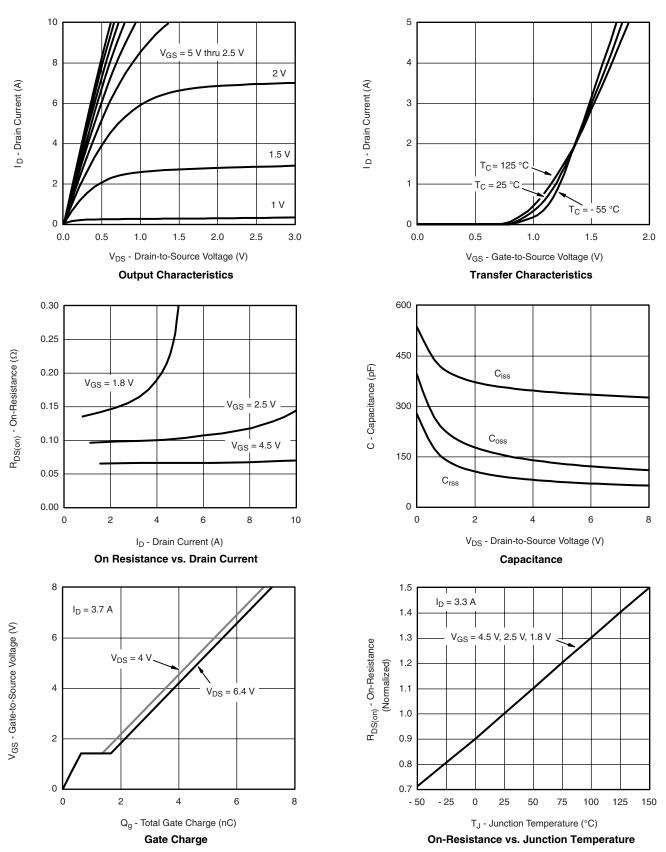
Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



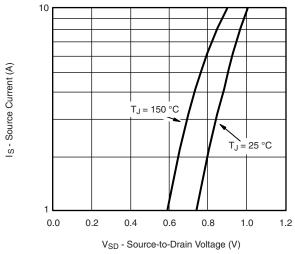
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



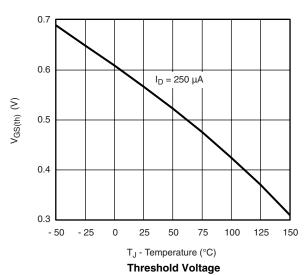
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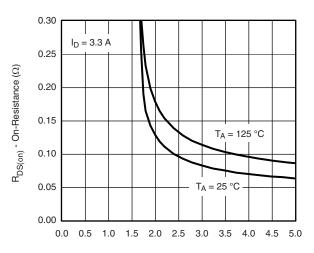
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

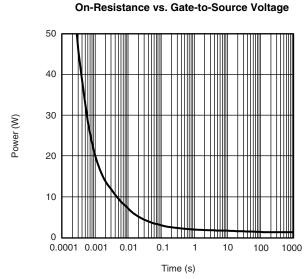


Forward Diode Voltage vs. Temperature

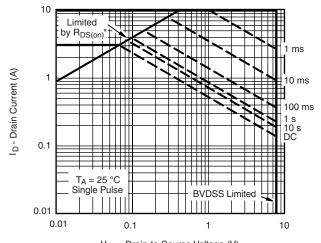




V_{GS} - Gate-to-Source Voltage (V)



Single Pulse Power



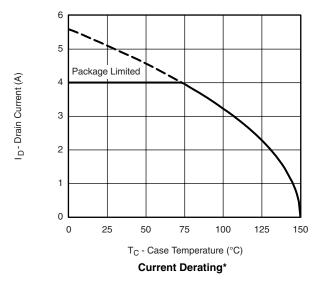
 $\label{eq:VDS} V_{DS} \text{ - Drain-to-Source Voltage (V)} \\ ^* V_{GS} > \text{minimum } V_{GS} \text{ at which } R_{DS(on)} \text{ is specified}$

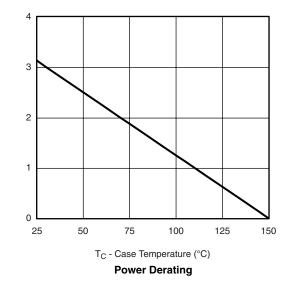
Safe Operating Area, Junction-to-Ambient





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





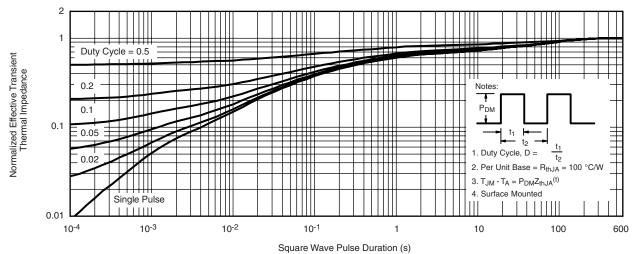
Power Dissipation (W)

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

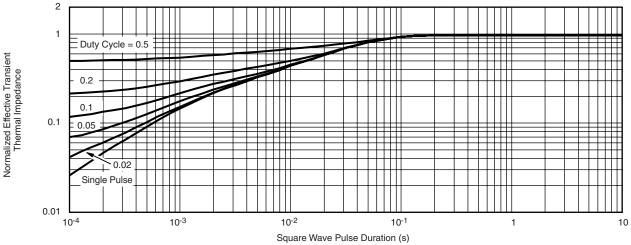
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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